

MAR06-2005-003099

Abstract for an Invited Paper  
for the MAR06 Meeting of  
the American Physical Society

**Scanning tunneling spectroscopy studies of  $\text{Bi}_2\text{Sr}_2\text{CaCu}_2\text{O}_{8+x}$  from the strongly underdoped to strongly overdoped regime**

JAMES SLEZAK, Department of Physics, Cornell University

Using atomically resolved scanning tunneling microscopy (STS), we investigate the electronic structure  $\text{Bi}_2\text{Sr}_2\text{CaCu}_2\text{O}_{8+x}$  across a range of doping levels from  $x \sim 0.1$  up to as high as  $\sim 0.23$ , with significant changes in electronic structure observed above  $p \sim 0.21$ . New sample preparation processes [1] were used to produce heavily overdoped crystals suitable for the imaging of various forms of electronic heterogeneity. The evolution of the gap map  $\Delta(\mathbf{r})$ , coherence peak height map  $A(\mathbf{r})$ , the inelastic tunneling signatures  $\omega(\mathbf{r})$ , and the quasiparticle interference LDOS modulations, as well as their interrelations across this range of doping levels, will be presented.

Additional authors: J. Lee, M. Wang, Laboratory of Atomic and Solid State Physics, Department of Physics, Cornell University, Ithaca, NY 14853, U.S.A; K. Fujita, Department of Advanced Materials Science, University of Tokyo, Tokyo 113-0033, Japan; H. Eisaki, National Institute of Advanced Industrial Science and Technology (AIST), 1-1-1 Central 2, Umezono, Tsukuba, Ibaraki 305-8568; S. Uchida, Department of Physics, University of Tokyo, Tokyo 113-0033; and J. C. Davis, Laboratory of Atomic and Solid State Physics, Department of Physics, Cornell University.

[1] J. Slezak, K. Fujita, J. C. Davis, in preparation (2005)